Unit: mm

TOSHIBA Field Effect Transistor Silicon N-Channel MOS Type ( -MOS VI)

## **TK15H50C**

#### **Switching Regulator Applications**

• Low drain-source ON resistance : RDS (ON) = 0. 33  $\Omega$  (typ.)

• High forward transfer admittance :  $|Y_{fs}| = 8.5 \mathrm{S}$  (typ.)

• Low leakage current :  $IDSS = 100 \mu A (max) (VDS = 500 V)$ 

• Enhancement mode :  $V_{th} = 2.0 \sim 4.0 \text{ V (V}_{DS} = 10 \text{ V, I}_{45D} = 1 \text{ mA})$ 

### **Maximum Ratings (Ta = 25°C)**

Characteri	stic	Symbol	Rating	Unit
Drain-source voltage		$V_{DSS}$	500	V
Drain-gate voltage (R	<sub>SS</sub> = 20 kΩ)	$V_{DGR}$	500	V
Gate-source voltage		V <sub>GSS</sub>	±30	V
Drain current	DC (Note 1)	I <sub>D</sub>	15	Α
	Pulse (Note 1)	I <sub>DP</sub>	60	Α
Drain power dissipation	n (Tc = 25°C)	P <sub>D</sub>	150	W
Single-pulse avalanche	e energy (Note 2)	E <sub>AS</sub>	765	mJ
Avalanche current		I <sub>AR</sub>	15	Α
Repetitive avalanche e	nergy (Note 3)	E <sub>AR</sub>	15	mJ
Channel temperature		T <sub>ch</sub>	150	°C
Storage temperature ra	ange	T <sub>stg</sub>	-55~150	°C

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Weight: 3.8 g (typ.)

**TOSHIBA** 

#### **Thermal Characteristics**

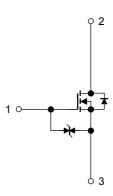
Characteristic	Symbol	Мах	Unit
Thermal resistance, channel to case	R <sub>th (ch-c)</sub>	0.833	°C/W
Thermal resistance, channel to ambient	R <sub>th (ch-a)</sub>	50	°C/W

Note 1: Ensure that the channel temperature does not exceed 150°C.

Note 2:  $V_{DD}$  = 90 V,  $T_{ch}$  = 25°C (initial), L = 5.78 mH,  $R_G$  = 25  $\Omega$ ,  $I_{AR}$  = 15 A

Note 3: Repetitive rating: pulse width limited by maximum channel temperature

This transistor is an electrostatic-sensitive device. Handle with care.



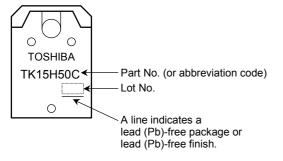
## **Electrical Characteristics (Ta = 25°C)**

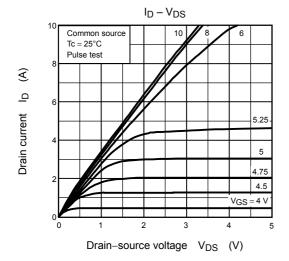
Charac	cteristic	Symbol	Test Condition	Min	Тур.	Max	Unit
Gate leakage cu	ırrent	I <sub>GSS</sub>	V <sub>GS</sub> = ±25 V, V <sub>DS</sub> = 0 V	_	_	±10	μΑ
Gate-source bre	eakdown voltage	V (BR) GSS	I <sub>G</sub> = ±10 μA, V <sub>DS</sub> = 0 V	±30	_	_	V
Drain cutoff curr	ent	I <sub>DSS</sub>	V <sub>DS</sub> = 500 V, V <sub>GS</sub> = 0 V	_	_	100	μA
Drain-source br	eakdown voltage	V (BR) DSS	I <sub>D</sub> = 10 mA, V <sub>GS</sub> = 0 V	500	_	_	V
Gate threshold v	oltage/	V <sub>th</sub>	V <sub>DS</sub> = 10 V, I <sub>D</sub> = 1 mA	2.0	_	4.0	V
Drain-source O	N resistance	R <sub>DS (ON)</sub>	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 7.0 A	_	0.33	0.4	Ω
Forward transfer	r admittance	Y <sub>fs</sub>	V <sub>DS</sub> = 10 V, I <sub>D</sub> = 7.0 A	4.0	8.5	_	S
Input capacitano	e	C <sub>iss</sub>		_	2450	_	
Reverse transfer capacitance		C <sub>rss</sub>	V <sub>DS</sub> = 25 V, V <sub>GS</sub> = 0 V, f = 1 MHz	_	15	_	pF
Output capacitance		Coss	]		220	_	
Switching time	Rise time	t <sub>r</sub>	$V_{GS} = 10V$ $V_{GS} = 10V$ $V_{OUT} = 10$	_	50	_	ns
	Turn-on time	t <sub>on</sub>		_	90	_	
	Fall time	t <sub>f</sub>		_	45	_	
	Turn-off time	t <sub>off</sub>	Duty $\leq 1\%$ , $t_{\mathbf{W}} = 10 \mu s$	_	175	_	
Total gate charg plus gate-drain)	,			48		nC	
Gate-source charge		Q <sub>gs</sub>	$V_{DD} \approx 400 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 15 \text{ A}$		26		_
Gate-drain ("Miller") charge		Q <sub>gd</sub>			22		

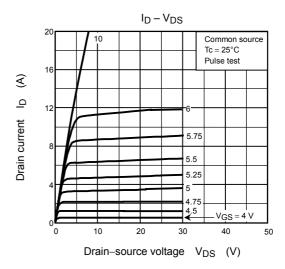
## Source-Drain Ratings and Characteristics (Ta = 25°C)

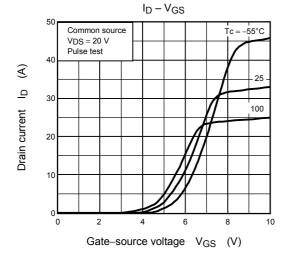
Characteristic	Symbol	Test Condition	Min	Тур.	Max	Unit
Continuous drain reverse current (Note 1)	I <sub>DR</sub>	_	-	_	15	Α
Pulse drain reverse current (Note 1)	I <sub>DRP</sub>	_	-	_	60	Α
Forward voltage (diode)	V <sub>DSF</sub>	I <sub>DR</sub> = 15 A, V <sub>GS</sub> = 0 V	_	_	-1.7	V
Reverse recovery time	t <sub>rr</sub>	I <sub>DR</sub> = 15 A, V <sub>GS</sub> = 0 V	_	1050	_	ns
Reverse recovery charge	Q <sub>rr</sub>	dl <sub>DR</sub> / dt = 100 A / μs	_	13	_	μC

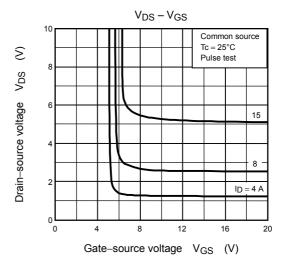
## Marking

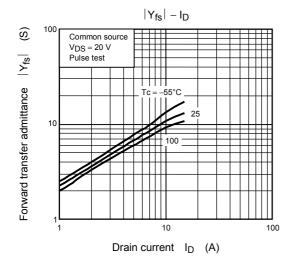


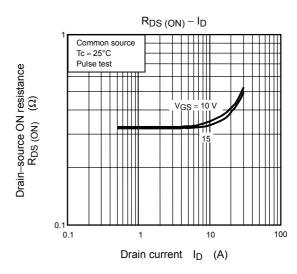




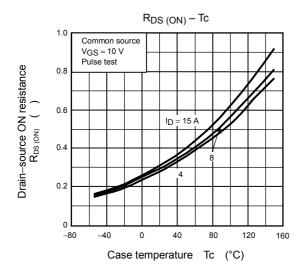


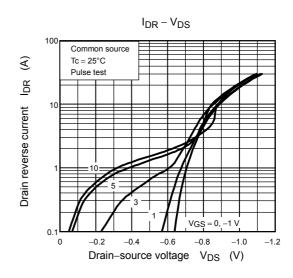


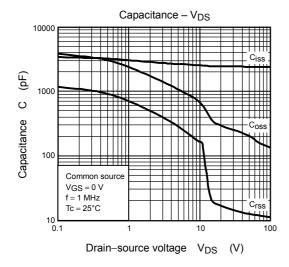


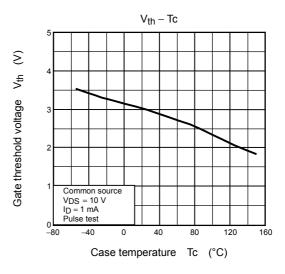


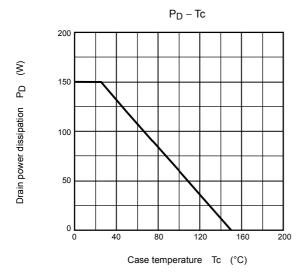
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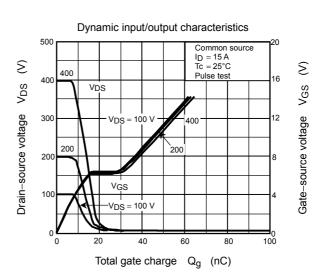




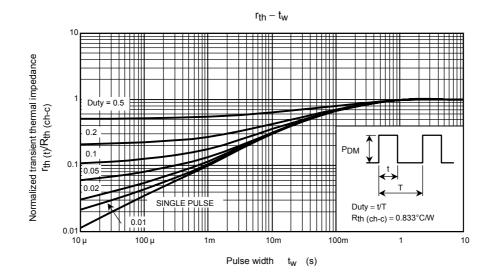




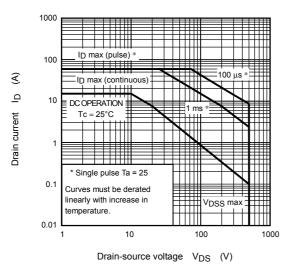


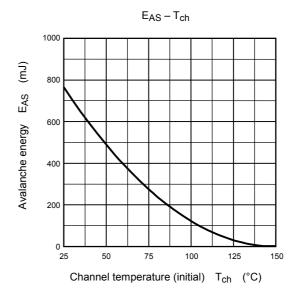


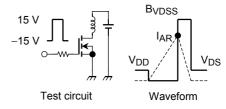
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$$\begin{aligned} R_G &= 25~\Omega \\ V_{DD} &= 90~\text{V, L} = 5.78~\text{mH} \end{aligned} \qquad \text{EAS} = \frac{1}{2} \cdot \text{L} \cdot \text{I}^2 \cdot \left( \frac{\text{BVDSS}}{\text{BVDSS} - \text{V}_{DD}} \right)$$

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